

INTERNATIONAL STANDARD

NORME INTERNATIONALE

**Solderless connections –
Part 3: Accessible insulation displacement (ID) connections – General
requirements, test methods and practical guidance**

**Connexions sans soudure –
Partie 3: Connexions autodénudantes accessibles – Règles générales, méthodes
d'essai et guide pratique**





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IEC Central Office
3, rue de Varembe
CH-1211 Geneva 20
Switzerland

Tel.: +41 22 919 02 11
info@iec.ch
www.iec.ch

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CONTENTS

| | |
|---|----|
| FOREWORD | 5 |
| INTRODUCTION | 7 |
| 1 Scope | 9 |
| 2 Normative references | 9 |
| 3 Terms and definitions | 10 |
| 4 Workmanship..... | 13 |
| 5 Prerequisites for basic test schedule | 13 |
| 5.1 General..... | 13 |
| 5.2 Prerequisites for accessible ID terminations..... | 14 |
| 5.2.1 Accessible ID termination materials | 14 |
| 5.2.2 Accessible ID termination dimensions..... | 14 |
| 5.2.3 Accessible ID termination surface finishes | 14 |
| 5.2.4 Accessible ID termination design features | 14 |
| 5.3 Prerequisites for wires and conductors..... | 14 |
| 5.3.1 Wires and conductors | 14 |
| 5.3.2 Wire insulation..... | 15 |
| 5.4 Accessible insulation displacement connections (accessible ID connections)..... | 15 |
| 6 Testing | 15 |
| 6.1 Introduction..... | 15 |
| 6.2 General..... | 15 |
| 6.3 Standard conditions for testing..... | 16 |
| 6.4 Preconditioning | 16 |
| 6.5 Recovery | 16 |
| 6.6 Mounting of specimen | 16 |
| 7 Tests | 16 |
| 7.1 General examination | 16 |
| 7.2 Mechanical tests | 17 |
| 7.2.1 Transverse extraction force | 17 |
| 7.2.2 Bending of the wire | 18 |
| 7.2.3 Vibration | 19 |
| 7.2.4 Repeated connection and disconnection, reusable accessible ID terminations..... | 20 |
| 7.3 Electrical tests | 20 |
| 7.3.1 General | 20 |
| 7.3.2 Contact resistance | 21 |
| 7.3.3 Electrical load and temperature | 22 |
| 7.4 Climatic tests | 22 |
| 7.4.1 General | 22 |
| 7.4.2 Rapid change of temperature..... | 22 |
| 7.4.3 Climatic sequence | 22 |
| 7.4.4 Flowing mixed gas corrosion test..... | 22 |
| 7.4.5 Damp heat, cyclic | 23 |
| 8 Test schedules | 23 |
| 8.1 General..... | 23 |
| 8.1.1 Overview | 23 |

| | | |
|-----------------------|---|----|
| 8.1.2 | ID connections with terminations suitable for a range of wire diameters | 23 |
| 8.1.3 | Multipole connectors | 23 |
| 8.2 | Basic test schedule | 24 |
| 8.2.1 | Généralités | 24 |
| 8.2.2 | Initial examination | 24 |
| 8.2.3 | Testing of accessible ID connections | 24 |
| 8.3 | Full test schedule | 26 |
| 8.3.1 | General | 26 |
| 8.3.2 | Initial examination | 26 |
| 8.3.3 | Testing of accessible ID connections | 26 |
| 8.4 | Flow charts | 29 |
| Annex A (informative) | Practical guidance | 32 |
| A.1 | General information on accessible ID connections | 32 |
| A.1.1 | General | 32 |
| A.1.2 | Advantages of accessible ID connections | 32 |
| A.2 | Current-carrying capacity | 33 |
| A.3 | Tool information | 33 |
| A.3.1 | Wire insertion tool | 33 |
| A.3.2 | Wire extraction tool | 33 |
| A.3.3 | Combination tool | 33 |
| A.4 | Termination information | 33 |
| A.4.1 | General | 33 |
| A.4.2 | Design features | 34 |
| A.4.3 | Materials | 34 |
| A.4.4 | Surface finishes | 34 |
| A.5 | Wire information | 34 |
| A.5.1 | Type | 34 |
| A.5.2 | Dimensions | 34 |
| A.5.3 | Surface finishes | 34 |
| A.5.4 | Insulation | 34 |
| A.6 | Connection information | 35 |
| Annex B (informative) | Application examples | 37 |
| B.1 | Examples for good IDCs or negative results (see Figure B.1 to Figure B.7) | 37 |
| B.2 | Examples for good transversal micro section or negative results | 39 |
| Bibliography | | 40 |
| Figure 1 | – Example of accessible and non-accessible insulation displacement connection | 7 |
| Figure 2 | – Insulation displacement connection | 11 |
| Figure 3 | – Slot | 12 |
| Figure 4 | – Beam | 13 |
| Figure 5 | – Test arrangement, transverse extraction force | 17 |
| Figure 6 | – Test arrangement, bending of the wire | 18 |
| Figure 7 | – Test arrangement, vibration | 19 |
| Figure 8 | – Test arrangement, contact resistance | 21 |
| Figure 9 | – Basic test schedule (see 8.2) | 30 |
| Figure 10 | – Full test schedule (see 8.3) | 31 |

Figure A.1 – Example of a single-type accessible ID termination with a solid round conductor..... 36

Figure B.1 – Example of correct and acceptable ID connections 37

Figure B.2 – Examples for good IDCs or negative results..... 37

Figure B.3 – Faulty IDC: damaged contacts 38

Figure B.4 – Requirements for open-ended IDCs 38

Figure B.5 – Faulty IDC: damaged wire..... 38

Figure B.6 – IDC: Wire position..... 39

Figure B.7 – IDC: transversal micro section 39

Table 1 – Minimum transverse extraction force 18

Table 2 – Vibration, preferred test severities 19

Table 3 – Contact resistance of accessible ID connections, maximum permitted values 21

Table 4 – Number of specimens required 24

Table 5 – Qualification test schedule – Test group 1 25

Table 6 – Qualification test schedule – Test group 2 25

Table 7 – Qualification test schedule – Test group 3 26

Table 8 – Qualification test schedule – Test group A..... 27

Table 9 – Qualification test schedule – Test group B..... 27

Table 10 – Qualification test schedule – Test group C 28

Table 11 – Qualification test schedule – Test group D 29

Table 12 – Qualification test schedule – Test group E..... 29

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SOLDERLESS CONNECTIONS –**Part 3: Accessible insulation displacement (ID) connections –
General requirements, test methods and practical guidance**

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International Standard IEC 60352-3 has been prepared by subcommittee 48B: Electrical connectors, of IEC technical committee 48: Electrical connectors and mechanical structures for electrical and electronic equipment.

This second edition cancels and replaces the first edition published in 1993. This edition constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- a) Subclause 7.2.2: reduce the limit of duration of contact disturbance to 1 μ s.
- b) Subclause 7.2.3: reduce the limit of duration of contact disturbance to 1 μ s.
- c) Transferred Clauses 9 to 13 to Annex A (informative).
- d) The figures were revised for clarity.

The text of this International Standard is based on the following documents:

| FDIS | Report on voting |
|---------------|------------------|
| 48B/2789/FDIS | 48B/2802/RVD |

Full information on the voting for the approval of this International Standard can be found in the report on voting indicated in the above table.

This document has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts in the IEC 60352 series, published under the general title *Solderless connections*, can be found on the IEC website.

The committee has decided that the contents of this document will remain unchanged until the stability date indicated on the IEC website under "<http://webstore.iec.ch>" in the data related to the specific document. At this date, the document will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

INTRODUCTION

The two following parts of IEC 60352 are available on solderless insulation displacement connections:

- Part 3: Accessible insulation displacement connections – General requirements, test methods and practical guidance;
- Part 4: Solderless non-accessible insulation displacement connections – General requirements, test methods and practical guidance.

NOTE In this document the term "insulation displacement" is abbreviated to "ID", for example "ID connection", "ID termination".

Figure 1 illustrates examples of accessible and non-accessible insulation displacement connections that clarify the difference among them.

Part 3 includes requirements and relevant tests (normative) as well as a practical guidance in Annex A (informative) for accessible ID connections.

Two test schedules are provided:

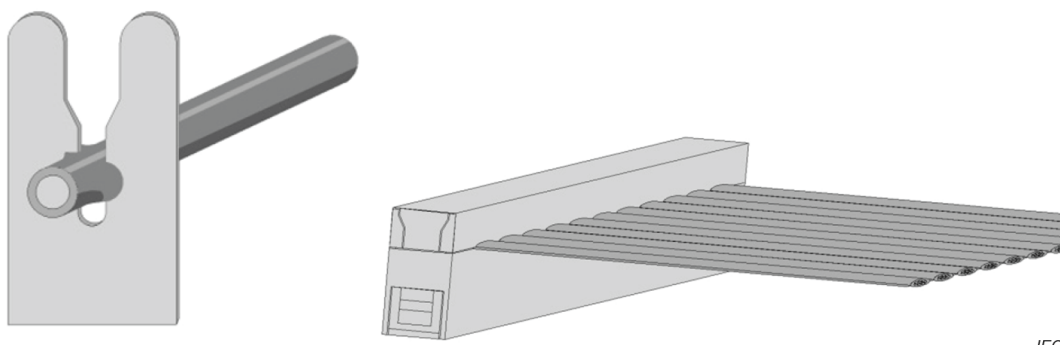
- the basic test schedule which applies to insulation displacement connections which conform to all prerequisites of Clause 5. It is derived from experience with successful applications of such connections;
- the full test schedule which applies to insulation displacement connections which do not fully conform to all prerequisites of Clause 5, for example which are manufactured using materials or finishes not included in Clause 5.

This philosophy permits cost and time effective performance verification using a limited basic test schedule for established insulation displacement connections and an expanded full test schedule for connections requiring more extensive performance validation.

The suitability of the accessible ID connection implies that the specified requirements and tests apply to all factors involved in producing a suitable ID connection, namely:

- the accessible ID termination, which may be part of a single-pole or multipole connector;
- the wire (or range of wires) for which the termination is suitable;
- the tools (if any) required to produce that type of solderless connection.

The practical guidance (informative Annex A) serves as a guideline for the required workmanship. Attention is drawn to the fact that some industries (e.g. automotive, aerospace, nuclear, military) may have specific workmanship standards and/or quality requirements, which are outside the scope of this standard.



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Figure 1 – Example of accessible and non-accessible insulation displacement connection

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